


<b>Search Notes</b>  	<b>Application/Control No.</b>  10790931	<b>Applicant(s)/Patent Under Reexamination</b>  TAKAYAMA ET AL.
	<b>Examiner</b>  Deborah Yee	<b>Art Unit</b>  1793

SEARCHED			
Class	Subclass	Date	Examiner
148	320,333-335,328,567,569,573-575,586,644,906	10/23/08	/DY/
384	912,625	10/23/08	/DY/

SEARCH NOTES		
Search Notes	Date	Examiner
up date inventorship and west search	10/23/08	/DY/

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
148	320,333-335,328,567,569,573-575,586,644,906	10/23/08	/DY/

--	--